

Search Notes

Application/Control No.

10/705,424

Examiner

Hieu Phan

Applicant(s)/Patent under
Reexamination

LITVACK ET AL.

Art Unit

3738

SEARCHED

Class	Subclass	Date	Examiner
update	Search	10/13/2005	☞

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR